Power MOSFET

40 V, 4.2 m Ω , 120 A, Single N–Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5832NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

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Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage			V _{GS}	± 20	V
Continuous Drain Cur-		T _{mb} = 25°C	Ι _D	120	А
rent R $_{\Psi J-mb}$ (Notes 1, 2, 3, 4)	Steady	$T_{mb} = 100^{\circ}C$		84	
Power Dissipation	State	T _{mb} = 25°C	PD	127	W
R _{ΨJ-mb} (Notes 1, 2, 3)		T _{mb} = 100°C		64	
Continuous Drain Cur-		$T_A = 25^{\circ}C$	I _D	21	А
rent $R_{\theta JA}$ (Notes 1, 3, 4)	Steady	T _A = 100°C		15	1
Power Dissipation	State	T _A = 25°C	PD	3.7	W
R _{θJA} (Notes 1 & 3)		T _A = 100°C		1.9	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	557	А
Operating Junction and Storage Temperature		T _J , T _{stg}	– 55 to + 175	°C	
Source Current (Body Diode)			۱ _S	120	А
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{GS} = 10 V, I _{L(pk)} = 52 A, L = 0.1 mH, R _G = 25 Ω)		E _{AS}	134	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\PsiJ-mb}$	1.2	°C/W
Junction-to-Ambient - Steady State (Note 3)	R_{\thetaJA}	40	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
Maximum current for pulses as long as 1 second is higher but is dependent

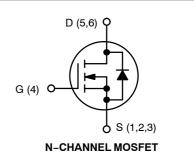
on pulse duration and duty cycle.

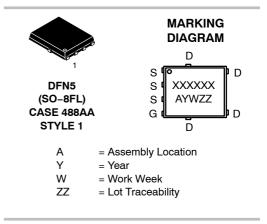


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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	$4.2 \text{ m}\Omega @ 10 \text{ V}$	100.4
40 V	6.5 mΩ @ 4.5 V	120 A





ORDERING INFORMATION

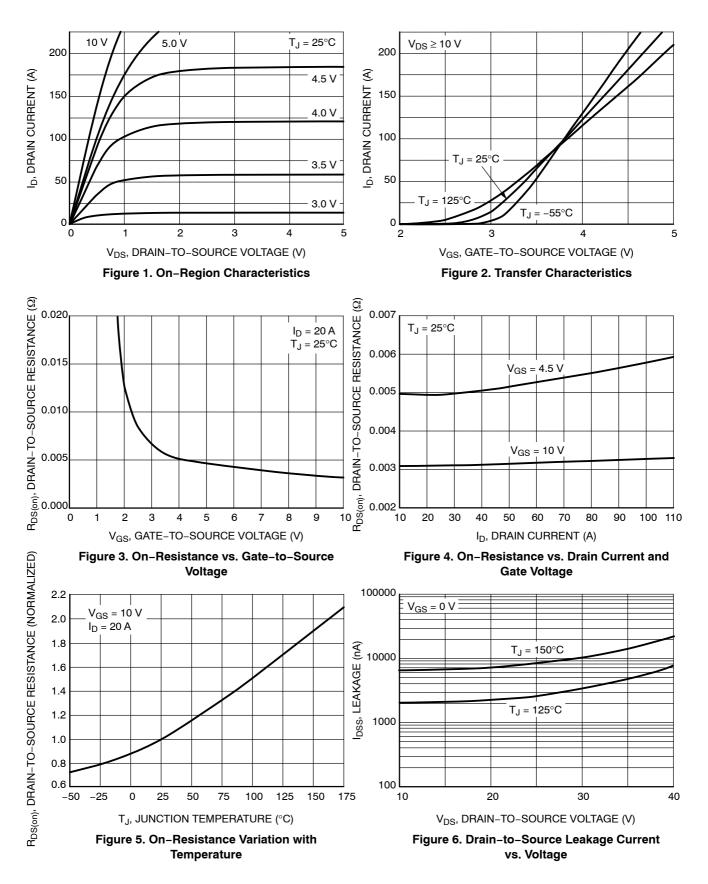
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

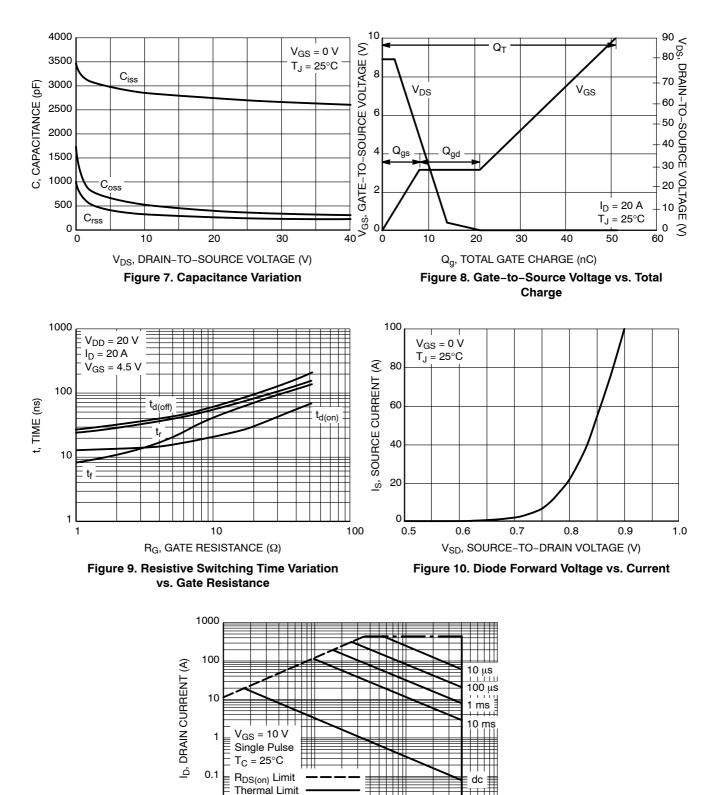
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				34.2		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	T _J = 25 °C			1	<u> </u>
		$V_{DS} = 40 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$				100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250 μA		1.4		2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 20 A		3.1	4.2	
		V _{GS} = 4.5 V	I _D = 20 A		5.0	6.5	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _D	= 20 A		21		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			2700		pF
Output Capacitance	C _{OSS}				360		
Reverse Transfer Capacitance	C _{RSS}				250		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 20 V; I_{D} = 20 A			25		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 20 V; I_{D} = 20 A			51		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 20 V; I _D = 20 A			2.0		nC V
Gate-to-Source Charge	Q _{GS}				8.0		
Gate-to-Drain Charge	Q _{GD}				12.7		
Plateau Voltage	V _{GP}				3.2		
SWITCHING CHARACTERISTICS (Note 6)							
Turn–On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 20 V, I _D = 10 A, R _G = 1.0 Ω			13		ns
Rise Time	t _r				24		
Turn-Off Delay Time	t _{d(OFF)}				27		
Fall Time	t _f				8.0		
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	V _{SD} V _{GS} = 0 V I _S = 5 A	$V_{GS} = 0 V_{c}$	$T_J = 25^{\circ}C$		0.73	1.2	
		$I_{\rm S} = 5 \rm A$	T _J = 125°C		0.57		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 10 A			28.6		ns
Charge Time	ta				14		
Discharge Time	t _b				14.5		
Reverse Recovery Charge	Q _{RR}				23.4		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V) Figure 11. Maximum Rated Forward Biased Safe Operating Area

Package Limit

1

0.01 0.1

10

100

TYPICAL CHARACTERISTICS

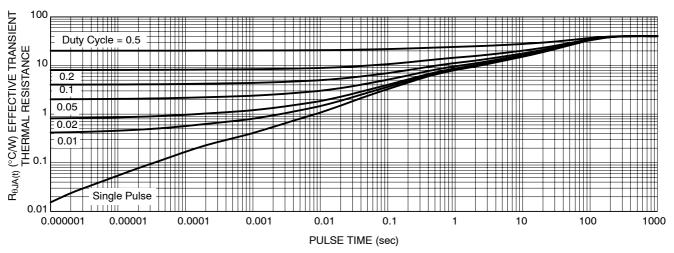


Figure 12. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS5832NLT1G	V5832L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5832NLWFT1G	5832LW	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5832NLT3G	V5832L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5832NLWFT3G	5832LW	DFN5 (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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